

- (amorphous crystn.; semiconductor devices having a **single crystal silicon** thin-film transistor formed on a glass substrate and fabrication thereof)
- IT 7440-59-7, Helium, uses 12385-13-6, Atomic hydrogen, uses (plasma; semiconductor devices having a **single crystal silicon** thin-film transistor formed on a glass substrate and fabrication thereof)
- IT 7439-88-5, Iridium, uses 7439-89-6, Iron, uses 7440-02-0, Nickel, uses 7440-04-2, Osmium, uses 7440-05-3, Palladium, uses 7440-06-4, Platinum, uses 7440-16-6, Rhodium, uses 7440-18-8, Ruthenium, uses 7440-22-4, Silver, uses 7440-48-4, Cobalt, uses 7440-50-8, Copper, uses 7440-57-5, Gold, uses (silicon crystn. catalyst; semiconductor devices having a **single crystal silicon** thin-film transistor formed on a glass substrate and fabrication thereof)

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126:138618 Semiconductor devices having **single crystal** thin-film transistors formed on glass substrates and fabrication thereof. Yamazaki, Shunpei; Teramoto, Satoshi (Handotai Energy Kenkyusho, Japan). Jpn. Kokai Tokkyo Koho JP 08298242 A2 19961112 Heisei, 16 pp. (Japanese). CODEN: JKXXAF. APPLICATION: JP 1995-125908 19950426.

AB The title process involves forming a sublayer on a glass substrate, forming an **amorphous Si film** on the sublayer, dehydrogenating the **Si film** by H-plasma treatment, heating or **laser-irradiating** for crystn., patterning to give **crystal seed layer**, depositing an **amorphous Si film** over the **seed layer**, heating or **laser-irradiating** to grow **single crystal** in the **Si film** from the **seeds**, and subsequently patterning the grown **Si film** to give **single cryst. regions** on the sublayer. The **single cryst. Si regions** are provided for active layers in thin-film transistors.

- IC ICM H01L021-20
ICS H01L029-786; H01L021-336
- CC 76-3 (Electric Phenomena)
- ST silicon **single cryst** thin film transistor; TFT **single cryst** silicon glass substrate
- IT Sputtering
(etching, hydrogen, dehydrogenation; semiconductor devices having **single crystal** thin-film transistors formed on glass substrates and fabrication thereof)
- IT Vapor deposition process
(plasma; semiconductor devices having **single**

- crystal** thin-film transistors formed on glass substrates and fabrication thereof)
- IT Dehydrogenation
Laser crystallization
 Thin film transistors
 (semiconductor devices having **single crystal** thin-film transistors formed on glass substrates and fabrication thereof)
- IT Etching
 (sputter, hydrogen, dehydrogenation; semiconductor devices having **single crystal** thin-film transistors formed on glass substrates and fabrication thereof)
- IT Glass, properties
 (substrate, transparent; semiconductor devices having **single crystal** thin-film transistors formed on glass substrates and fabrication thereof)
- IT 7440-21-3, Silicon, properties
 (amorphous; semiconductor devices having **single crystal** thin-film transistors formed on glass substrates and fabrication thereof)
- L145 ANSWER 17 OF 40 HCA COPYRIGHT 2004 ACS on STN
 112:14609 Lateral epitaxy. Nishigaki, Yuji; Yamagata, Kenji; Yonehara, Takao (Canon K. K., Japan). Jpn. Kokai Tokkyo Koho JP 01042117 A2 19890214 Heisei, 7 pp. (Japanese). CODEN: JKXXAF. APPLICATION: JP 1987-198688 19870808.
- AB The title method entails formation of fine particles of a material on a surface with a small nucleation d. (e.g., amorphous insulator), melt-solidification of the material for formation of **seed** crystals, and growth therefrom. Thus, an **amorphous Si film** 0.2 .mu.m thick on a quartz glass plate was photolithog. patterned with spots 1 .mu.m in diam., the spots were **annealed** by a **laser** beam, and Si **single crystals** 40 .mu.m in diam. and (100) oriented parallel to the substrate were grown at 950.degree. in substrate temp. from SiH₂Cl₂-HCl-H₂ in 30 min.
- IC ICM H01L021-20
 ICS H01L021-263; H01L021-268
- CC 75-1 (Crystallography and Liquid Crystals)
- IT Epitaxy
 (lateral, from fine **seeds** on low-nucleation d. surfaces)
- IT Epitaxy
 (vapor-phase, lateral, of silicon from fine **seeds** on quartz glass surface)
- IT 7440-56-4, Germanium, uses and miscellaneous
 (lateral VPE of gallium arsenide from fine **seeds** of, on quartz glass)